


<b>Search Notes</b> 	<b>Application/Control No.</b> 10602540	<b>Applicant(s)/Patent Under Reexamination</b> TUOMAINEN ET AL.
	<b>Examiner</b> MYLINH TRAN	<b>Art Unit</b> 2179

SEARCHED			
Class	Subclass	Date	Examiner
715	764, 802, 810, 809, 864, 825, 739, 840	7/16/2010	MLT

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, USPGPUB, EPO, JPO, DERWENT, IBM-TDB, NPL	7/16/2010	MLT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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